

Search Notes

Application/Control No.

10/622,609

Examiner

Tianjie Chen

Applicant(s)/Patent under
Reexamination

NAKATA, EIJI

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
720	646	10/17/2006	TJ

INTERFERENCE SEARCHED

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720	646	10/17/2006	TJ

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Report	10/17/2006	TJ